FORM HDP-1449 (Based on Form PTO-1449)

PATENT AND TRADEMARK OFFICE

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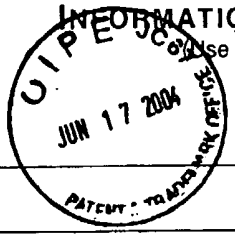
Sheet 1 of 2



ATTORNEY DOCKET NO.	SERIAL NO.
9692-000006/US/COA	10/682,322
APPLICANT	
Wulf, Jurgen	
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October 9, 2003	~~1744~~ 1743

U.S. PATENT DOCUMENTS

Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
1.		4,583,860	4/22/1986	Butner		
2.		4,770,517	09/13/1988	Sakuma		
3.		5,118,181	06/2/1992	Yifrach et al.		
4.		5,164,844	11/17/1992	Granger		
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7.		5,585,639	12/17/1993	Dorsel et al.		
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12.		EP 0 360 233 A2	03/28/1990	Europe			
13.		EP 0 425 426 A2	05/02/1991	Europe			
14.		EP 0 627 643 A2	12/07/1994	Europe			
15.		EP 0 713 086 A1	05/22/1996	Europe			
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17.		JP 9049794	02/18/1997	Japan			
18.		43 07 042 A1	08/09/1994	Germany			

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FOREIGN PATENT DOCUMENTS

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19.		WO 92/06366	04/16/1992	Germany			No

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)

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20.		"Scanning Laser Microscopy Lab, Our Microscopes," University of Waterloo, http://www.science.uwaterloo.ca/physics/research/confocal/microsc.html, last updated 8/10/1999, five pages
21.		"Abakus 3.5mm f/8 High Definition Stadium Lens," Innovision Optics, Inc., Santa Monica, CA, date unknown, one page.
22.		"Applications of Fixed Focus Technology in Laser Marking Systems, Fixed Field Size vs. VariField™," Alase Technologies, Pepperell, MA, http://www.alase.com/applications/ftheta.html, 1997-2002, two pages.

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